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APPLICATION NO		FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/078,473		02/21/2002	Hoki Kwon	V637-02992 US	4854	
22913	7590	03/28/2005		EXAM	EXAMINER	
WORKM		EGGER NYDEGGER & SEE	NGUYEN,	NGUYEN, DUNG T		
60 EAST S			ART UNIT	PAPER NUMBER		
1000 EAGLE GATE TOWER				2828		
SALT LAKE CITY, UT 84111				DATE MAILED: 03/28/2005		

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)				
Office Antique Comments	10/078,473	KWON, HOKI				
Office Action Summary	Examiner	Art Unit				
	Dung (Michael) T. Nguyen	2828				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply						
A SHORTENED STATUTORY PERIOD FOR REPL' THE MAILING DATE OF THIS COMMUNICATION. Extensions of time may be available under the provisions of 37 CFR 1.1 after SIX (6) MONTHS from the mailing date of this communication. If the period for reply specified above is less than thirty (30) days, a repl' If NO period for reply specified above, the maximum statutory period to Failure to reply within the set or extended period for reply will, by statute Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be tim y within the statutory minimum of thirty (30) days vill apply and will expire SIX (6) MONTHS from t , cause the application to become ABANDONED	ely filed will be considered timely. the mailing date of this communication. (35 U.S.C. § 133).				
Status						
1) Responsive to communication(s) filed on 21 D	ecember 2004.					
	action is non-final.					
3) Since this application is in condition for allowar	<u></u>					
closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.						
Disposition of Claims						
4) Claim(s) <u>1-21</u> is/are pending in the application. 4a) Of the above claim(s) is/are withdrawn from consideration.						
5) Claim(s) is/are allowed.						
<u> </u>	Claim(s) is/are allowed. Claim(s) 1-21 is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restriction and/or election requirement.					
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<u> </u>						
Application Papers						
9) The specification is objected to by the Examiner. 10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.						
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).						
11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.						
Priority under 35 U.S.C. § 119						
12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).						
a) All b) Some * c) None of:						
1.☐ Certified copies of the priority documents have been received.						
2. Certified copies of the priority documents have been received in Application No.						
3. Copies of the certified copies of the priority documents have been received in this National Stage						
application from the International Bureau (PCT Rule 17.2(a)).						
* See the attached detailed Office action for a list of the certified copies not received.						
Attachment(s)						
Attachment(s) 1) Notice of References Cited (PTO-892) 4) Interview Summary (PTO-413)						
2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	Paper No(s)/Mail Da	te				
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date <u>01/28/05</u> .	5) Notice of Informal Pa	atent Application (PTO-152)				

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DETAILED ACTION

Response to Arguments

Applicant's arguments with respect to claims 1-21 have been considered but are most in view of the new ground(s) of rejection.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claim 8 is rejected under 35 U.S.C. 102(b) as being anticipated by Bedair et al. (H667). Bedair disclose in Fig.2 a p-doped GaAs(1-x)Sbx tunnel junction layer 203 (col.7, 1.16-17).

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

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Claims 1-7 and 9-12 are rejected under 35 U.S.C. 103(a) as being unpatentable over Bedair et al. (H667) in view of McDermott et al. (Growth and doping of GaAsSb via metalorganic chemical vapor deposition for InP heterojunction bipolar transistors in Appl. Phys. Lett., Vol.68, No. 10, 4 March 1996).

With respect to claims 1-2, Bedair disclose in Fig.2 a tunnel junction including GaAs(1-x)Sbx 203 (col.7, 1.16-17). Bedair lack a substrate in an MOCVD chamber between 500 C and 650 C. McDermott teach a substrate in an MOCVD chamber (page 1386, second column, line 11-12) between 500 C and 600 C which meet the claim limitation of between 500 C and 650 C (page 1386, second column, line 5). For the benefit of manufacturing a reliable tunnel junction layer in a VCSEL, it would have been obvious to one having ordinary skill in the art at the time the invention was made to provide Bedair what is taught by McDermott.

With respect to claims 5-7, McDermott disclose TEGa, CCl4 (p.1386, first col., fourth para., 1.5-6), TMSb, and AsH3 (p.1386, second col., 1.14).

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With respect to claim 9, McDermott disclose the GaAsSb layer is doped with carbon with a concentration greater than 1x10sub19 cm-3 (page 1386, first column).

With respect to claim 10, McDermott disclose the InP layer (page 1387, second column, line 3).

With respect to claim 11, Bedair disclose the tunnel junction is less than about 10 nm thick (col.5, 1.37).

With respect to claims 3-4 and 12, McDermott disclose the x value of 0.5 (page 1386, second column, line 11).

Claims 13-15, 18, and 21 are rejected under 35 U.S.C. 103(a) as being unpatentable over Bedair et al. (H667) in view of the admitted prior art.

With respect to claims 13 and 18, Bedair disclose in Fig.2 a tunnel junction including GaAs(1-x)Sbx 203 (col.7, 1.16-17). Bedair lack the InGaAsP active region having a plurality of quantum wells. Prior art teaches in Fig.1 the InGaAsP active region 20 having a plurality of quantum wells. For the benefit of obtaining a

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VCSEL with long wavelength using the tunnel junction, it would have been obvious to one having ordinary skill in the art at the time the invention was made to provide Bedair what is taught by Prior art.

With respect to claims 14-15, the prior art shows in Fig. 1 a bottom DBR 16, a bottom spacer 18, an active region 20, a top spacer 22, and a top DBR 24.

Claims 16-17 and 19-21 are rejected under 35 U.S.C. 103(a) as being unpatentable over Bedair et al. (H667) in view of the admitted prior art and further in view of McDermott et al. (Growth and doping of GaAsSb via metalorganic chemical vapor deposition for InP heterojunction bipolar transistors in Appl. Phys. Lett., Vol.68, No. 10, 4 March 1996).

With respect to claim 16, Bedair and Prior art disclose all limitations of the claim except for the MOCVD. McDermott teach the MOCVD (p.1386, third para.). For the benefit of manufacturing a tunnel junction for a long wavelength VCSEL, it would have been obvious to one having ordinary skill in the art at the time the invention was made to provide Bedair and Prior Art what is taught by McDermott.

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With respect to claim 17, McDermott disclose the GaAsSb layer is doped with carbon with a concentration greater than 1x10sub19 cm-3 (page 1386, first column).

With respect to claim 19, McDermott disclose the InP layer (page 1387, second column, line 3).

With respect to claim 20, McDermott disclose the x value of 0.5 (page 1386, second column, line 11).

With respect to claim 21, Bedair disclose the tunnel junction is less than about 10 nm thick (col.5, 1.37).

Communication Information

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Dung (Michael) T Nguyen whose telephone number is (571) 272-1949. The examiner can normally be reached on 8:30 - 17:00.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Min Harvey can be reached on (571) 272-1835. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 306-3329.

Michael Dung Nguyen

MINSUN CHLUSTY